

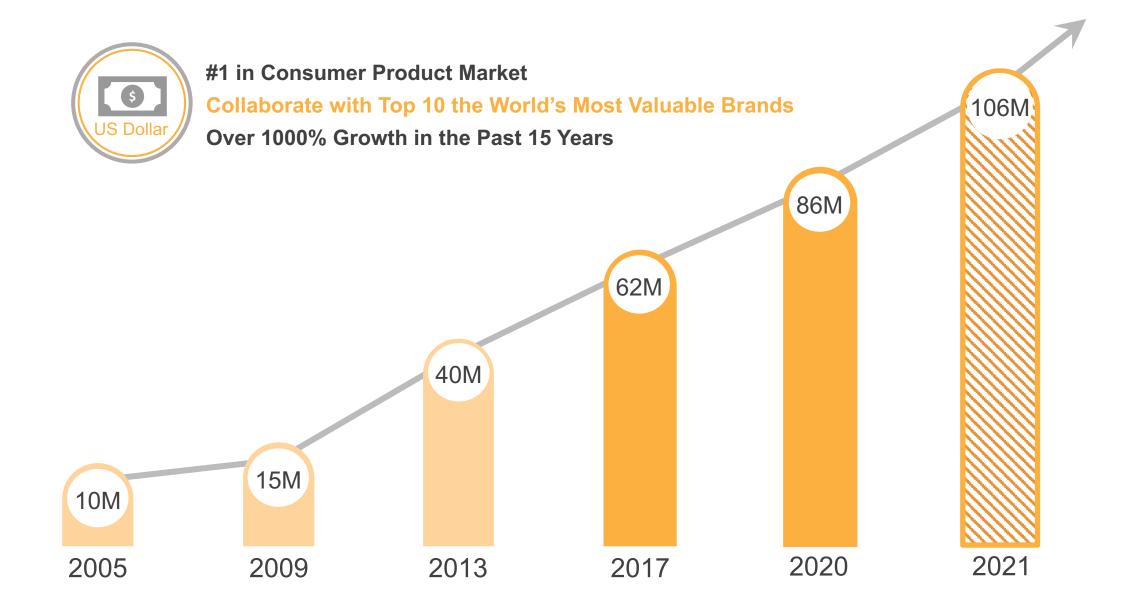
# **CCP Contact Probes**

# **Testing Solution**

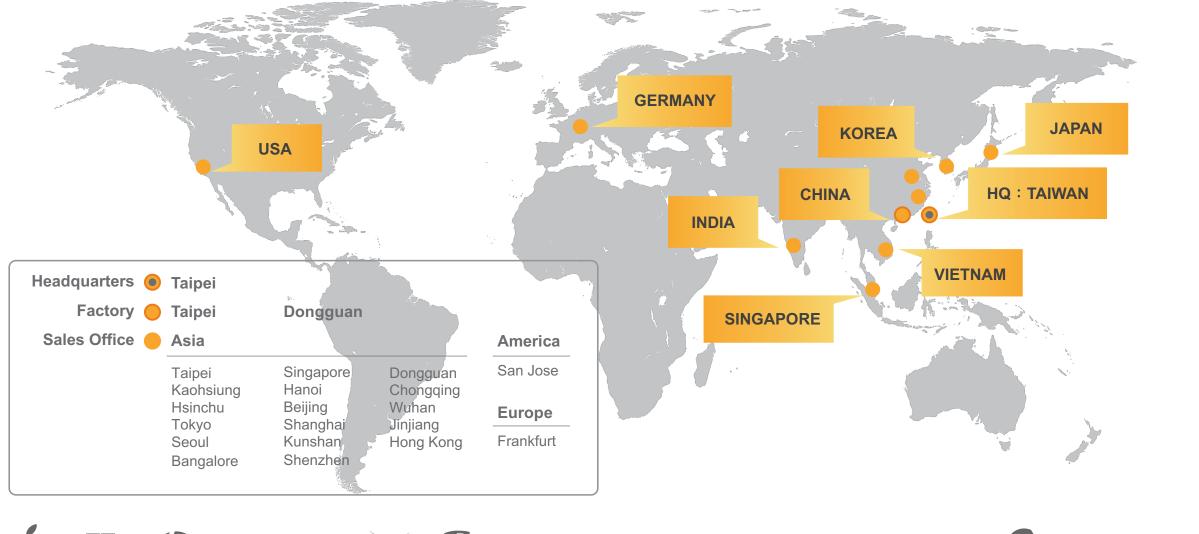
The state

100 mg

**CCP Contact Probes - Growth** 



## **CCP Contact Probes - Worldwide**





# **CCP Contact Probes - History**

2020 New Product Line: High Speed Network Cable 2020 Korea Subsidiary established.

2019 Japan Singapore Sub and India Office established.

2018 Germany Subsidiary established.

2016 Industrial Connector & Crown Spring Connector.

2014 CCP US Subsidiary established.

2012 Set up 100k class clean room production line.

2006 IC Testing

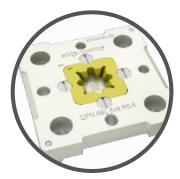
2003 Listed in Taiwan Stock Market (TW.6217).

2002 Pogo Pin Connector

2001 Dongguan CCP Contact Probes Co., Ltd established. 1986 ICT Testing

1986 CCP Contact Probes Co., Ltd. Established.

# **CCP Contact Probes - Product Portfolio**



Testing Solution Fine Pitch

IC Testing Probe PCB Testing Probe Testing Socket



Pogo Pin Connector

Pogo Pin Conn. Waterproof Conn. Magnetic Conn.



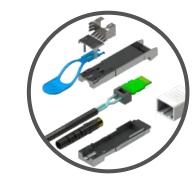
## High Current Connector

13A~250A

Electronic Vehicle High Current Conn.



Medical Connector Environmental Sensitivity Circular Conn. Endoscope Conn.



High Speed Cable 25Gbps~100Gbps Server Switch Telecom



Industrial Solution Extreme Environment Aerospace Military Transportation



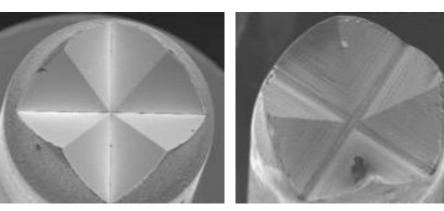
#### High Frequency Simulation



HFSS

**Other Provider** 

#### Mirror Process



**CCP's Product** 

#### **Material Development**

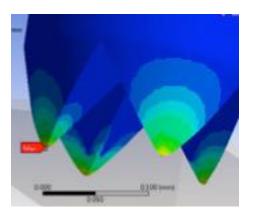




Plating Lab

Self-owned Plating Factory

#### **Finite Element Analysis**

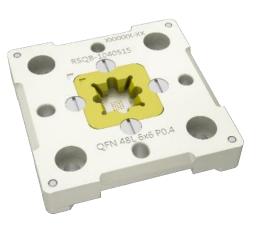


ANSYS

# **Testing Solution Product Line**



#### IC Package Test



#### **Burn-In Test**



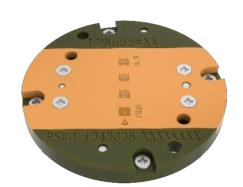
#### **High Frequency Test**



**Memory Test** 



**WLCSP** Test



**Battery Test** 



# **Testing Solution - IC Test Probe**



#### General Final Test



**Burn-In Test** 





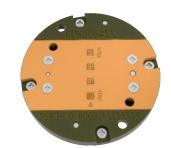


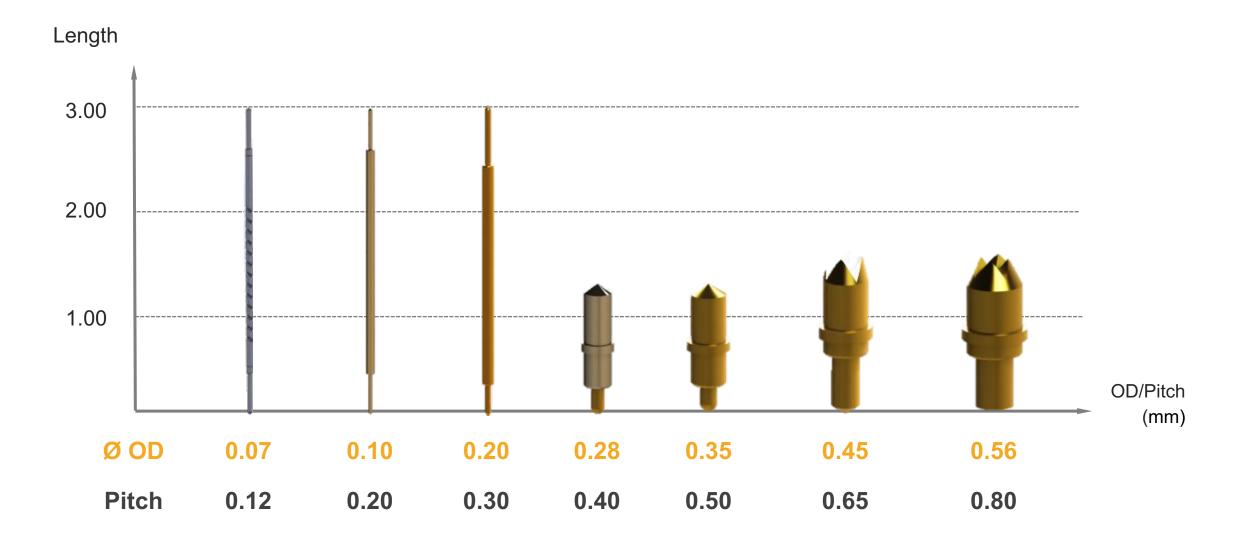
High Frequency Test



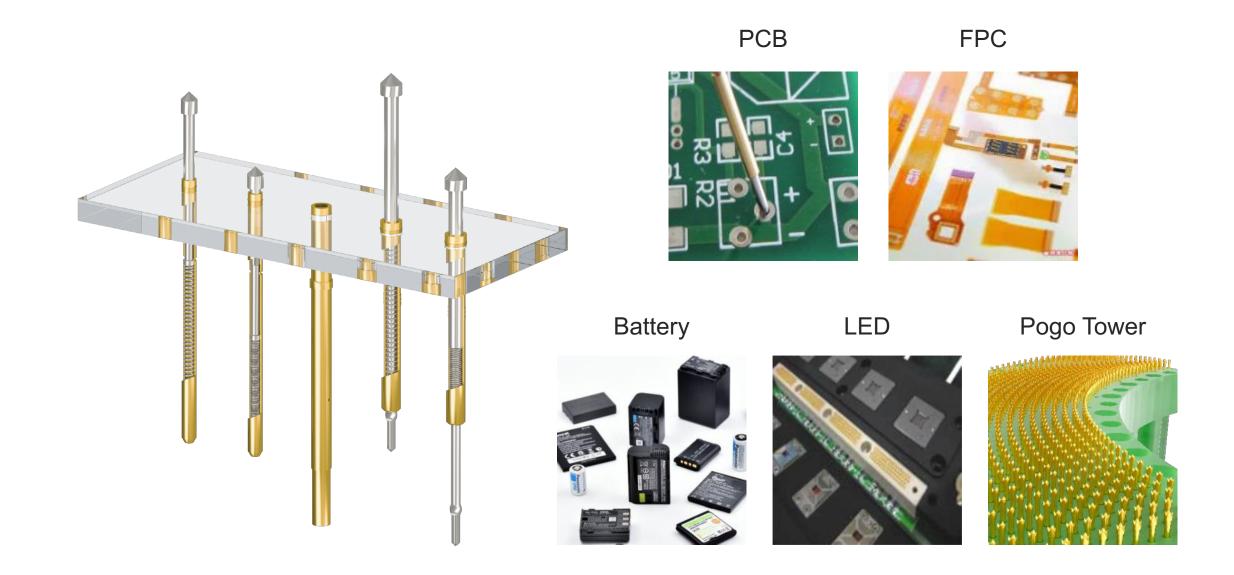
Wafer Level Test

**Fine Pitch Test** 





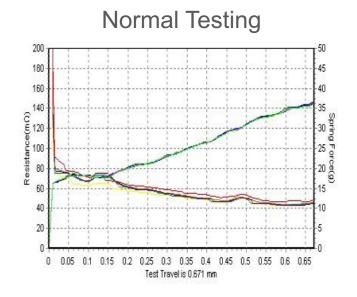
# **Testing Solution - ICT Test Probe**



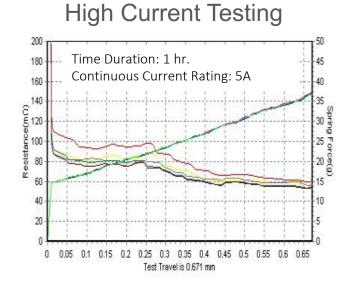
# **Testing Solution - High Current Probe**

#### Patent No. M453149





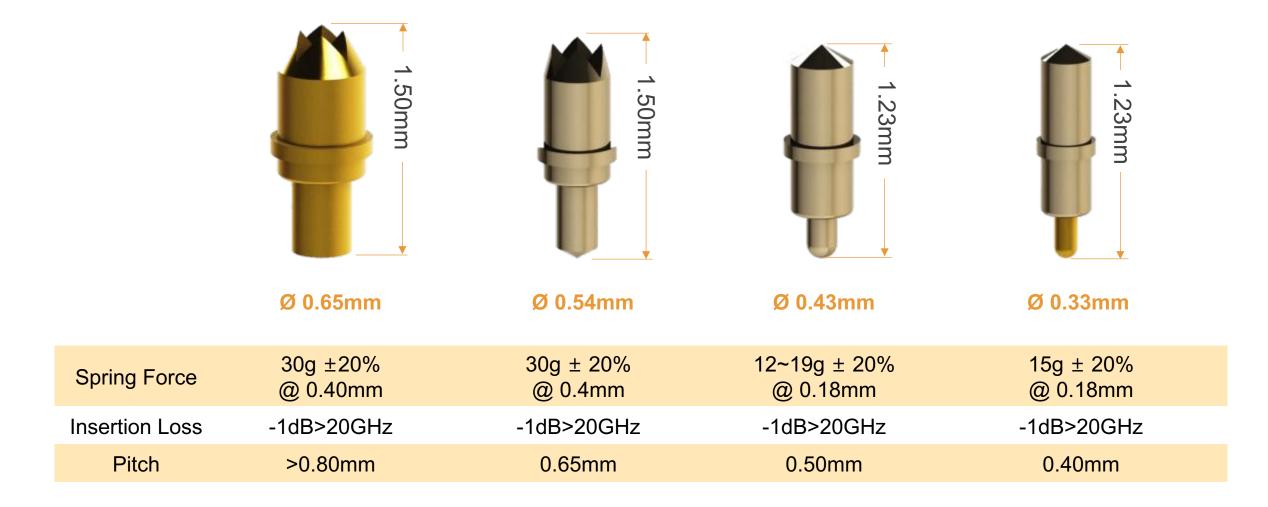
CCP Concentric Pin	
Stroke	0.60mm
Contact force	30 g (Adjustable)
Durability	Contacts : >30k
Pitch	0.650mm
DC resistance	< 60mΩ
<b>Current Rating</b>	5A





**Temperature Record** 

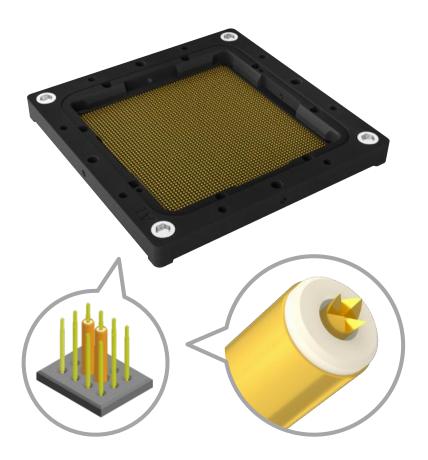
# **Testing Solution - High Frequency Probes**



# **Testing Solution - High Frequency Socket**

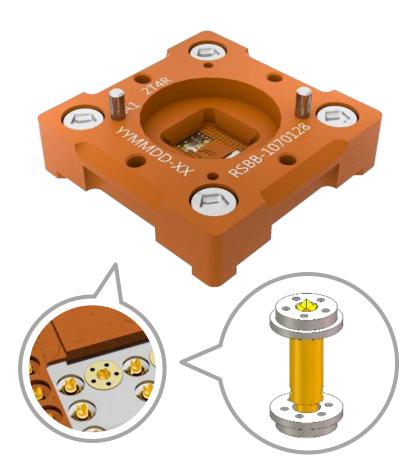
**5G IC** 

Coaxial Probe Socket

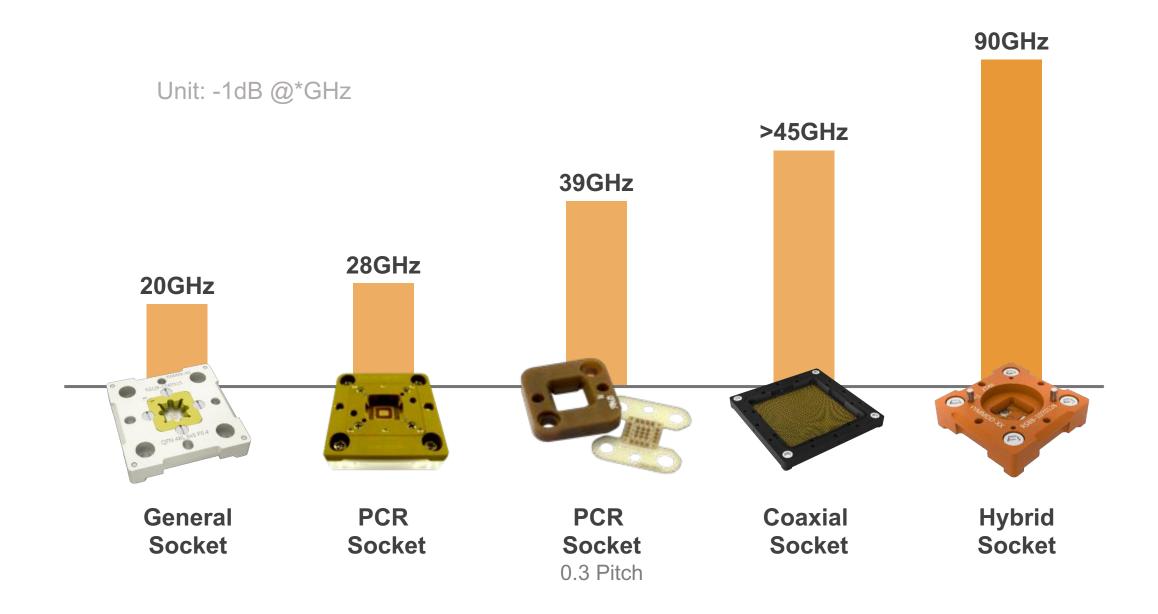


#### **ADAS**

Hybrid Coaxial Socket



**Testing Solution - High Frequency Socket** 



# **Testing Solution - Fine Pitch Test Fixture**

#### Dual-Side Pogo Socket

Min Pitch: 0.2 Mechanical Life: 200k

#### Clip Pogo Socket Min Pitch: 0.2 Mechanical Life: 200k



# **Testing Solution - IC Final Test Socket**







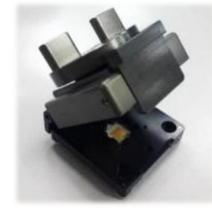
#### Memory Test

DDR 1~4 eMCP Flash



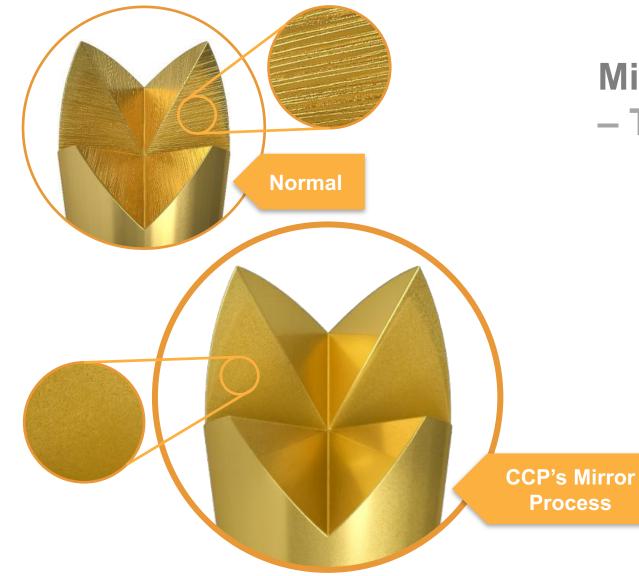


#### Clamping Lid QFN QFP <200 pins



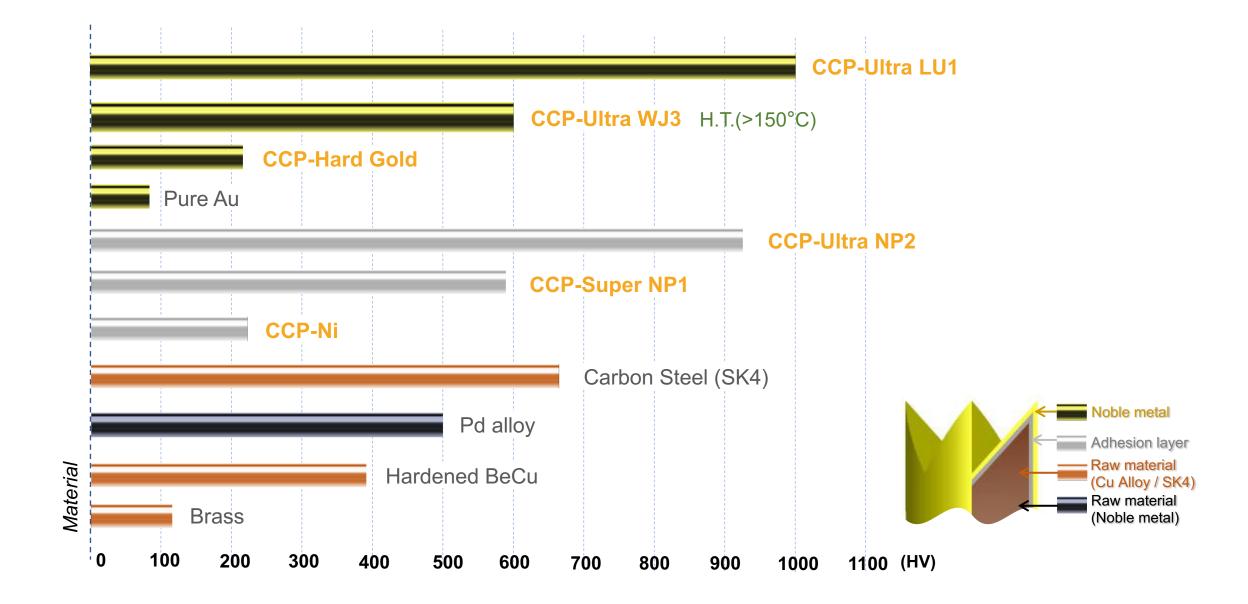
Knob Lid All Kind >200 pins

# **Testing Solution - Mirror Process**



# Mirror Process – The Best Probe Protector

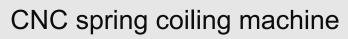
- The Mirror Process make the surface as smooth as mirror so that solder splashes won't attach on the probe tip. This, in turn, decreases your probe cleaning frequency, as well as machine down time significantly.
- Pin durability increase 1.3~1.5 times as compared to normal process.



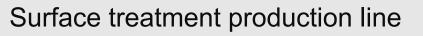
# **Testing Solution - Integrated Manufacturing**



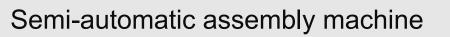














Automatic assembly machine



Automatic probe full inspection













# **Testing Capability - Test Equipment**

Turning Parts Surface Inspection



#### **Optical Profiler**

Surface Roughness Inspection

#### **Plating Layer Inspection**



#### Nanoindenter

- Hardness measurement
- Adhesion Test



#### FE-SEM and EDS

- Surface profile observation
- Material analysis

# **Testing Capability - Test Equipment**

#### **Electrical Performance**



Network Analyzer



**Mechanical Performance** 

Safety Comprehensive Analyzer

Mechanical

Vibration/Shock



**Automatic Insertion Force** Tester



Other

**Hot-Air Reflow** machine



**VNA** Vector Network Analyzer)



**High Current Power Supply & Electronic Load** 



Contact Resistance Tester



**RCA** Tape Abrasion Tester



Flush test chamber

Waterproof test

machine



**Durability** Cycling Machine

**3D** laser scanning microscope



X-ray



Electrochemical workstation



**Terminal cross** section analyzer



Oven



Thermal shock test machine





Salt spray test machine



**Temperature &** humidity test machine













# **Create Value for Customers**

Design for Manufacturing Components

Precision Machining

0

0

Connectors/

# **OUR** SERVICE

OUR

VALUE

Surface Treatment

In-House Lab/ Analysis Ability **Solution Service Engineering Service Design for Manufacturing** Customization Flexible Production. Local and Instant Support



# **Quality System**

ISO 9001:2015 Quality Management Systems

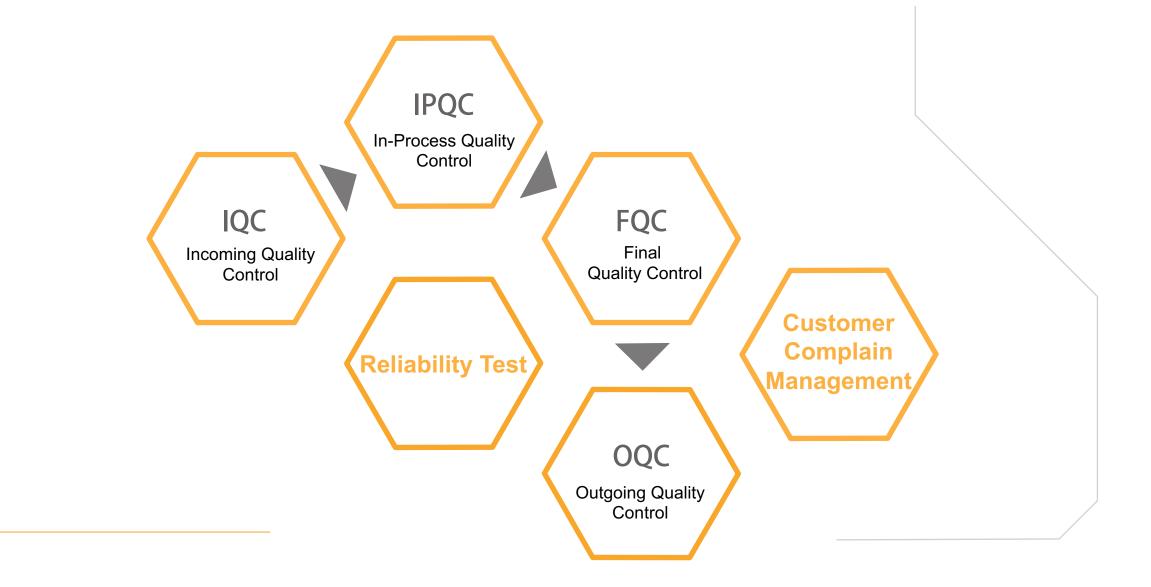
ISO 14001 : 2015 Environment Management Systems IATF 16949:2016 Automotive Quality Management System

QC 080000 Hazardous Substance Process Management

ISO 13485:2016

Medical Devices Quality Management Systems





# **Testing Items**

#### Environmental

Waterproof Humidity Test Salt Spray Thermal Impact Resist. to Solder Heat Vibration

### Electrical

Contact Resistance Insulation HIPOT Rated Current

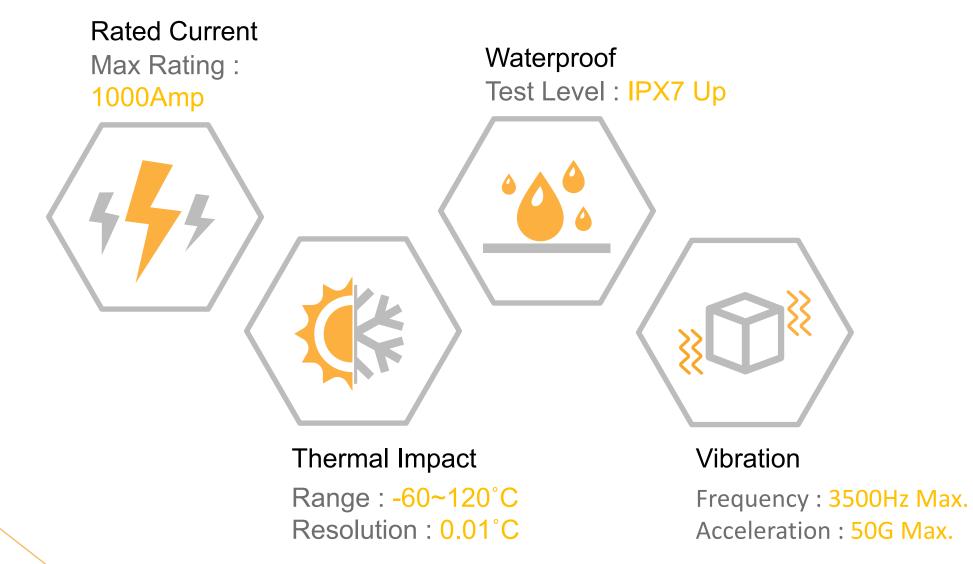
#### Mechanical

Retention Force Life Cycle Vibration Mechanical Shock

Other

Drop Soldering Side Force Solderability

# Testing Equipment



ISO 9001 ISO 13485 ISO 14001 ISO 14064 IATF 16949 IECQ QC080000

Certificate















Summer camp for employees' children





Home visit to employees around the world





CCP offers tuition scholarship for employees' children



# **CCP Contact Probes**

 $\mathbf{A8Q}$ 

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